Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/743,641	CHANG ET AL.	
Examiner	Art Unit	
Michael La Villa	1775	

SEARCHED				
Class	Subclass	Date	Examiner	
428	660, 671, 674, 675, 680	3/20/2006	ML	
72	199			
148	516, 527			
148	536, 421			
228	101, 117			
	262.1			
	262.3			
	262.6			
	262.61			
	262.31			
	262.71			
228	262.72	3/20/2006	ML	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	CH NOTES EARCH STRATEGY	·)
	DATE	EXMR
WEST SEARCH	3/4/2006	ML
WEST SEARCH	3/20/2006	ML
Inventor Search	3/20/2006	ML